

<b>Notice of References Cited</b>	Application/Control No. 10/046,249	Applicant(s)/Patent Under Reexamination KIGUCHI ET AL.	
	Examiner Gail Verbitsky	Art Unit 2859	Page 1 of 1

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	B	US-6,768,556	07-2004	Matsumoto et al.	356/601
	C	US-6,710,331	03-2004	Narita et al.	250/234
	D	US-2004/0188602	09-2004	Chinn et al.	250/234
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**NON-PATENT DOCUMENTS**

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